inter_{sil}

DATASHEET

HA-2600

12MHz, High Input Impedance Operational Amplifier

HA-2600 is an internally compensated bipolar operational amplifier that features very high input impedance (500M Ω) coupled with wideband AC performance. The high resistance of the input stage is complemented by low offset voltage (0.5mV) and low bias and offset current (1nA) to facilitate accurate signal processing. Input offset can be reduced further by means of an external nulling potentiometer. 12MHz unity gain-bandwidth, 7V/µs slew rate and 150kV/V open-loop gain enables the HA-2600 to perform high-gain amplification of fast, wideband signals. These dynamic characteristics, coupled with fast settling times, make this amplifier ideally suited to pulse amplification designs as well as high frequency (e.g. video) applications. The frequency response of the amplifier can be tailored to exact design requirements by means of an external bandwidth control capacitor.

In addition to its application in pulse and video amplifier designs, the HA-2600 is particularly suited to other high performance designs such as high-gain low distortion audio amplifiers, high-Q and wideband active filters and highspeed comparators.

Ordering Information

PART NUMBER	PART MARKING	TEMP. RANGE (°C)		
HA2-2600-2	HA2-2600-2	-55 to 125	8 Pin Metal Can	T8.C

FN2902 Rev 7.00 January 16, 2006

Features

• Bandwidth 12MHz
High Input Impedance 500MΩ
Low Input Bias Current
Low Input Offset Current 1nA
Low Input Offset Voltage 0.5mV
• High Gain 150kV/V
• Slew Rate

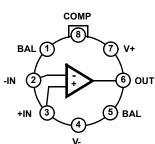
- Output Short Circuit Protection
- Unity Gain Stable

Applications

- Video Amplifier
- Pulse Amplifier
- · Audio Amplifiers and Filters
- High-Q Active Filters
- · High-Speed Comparators
- · Low Distortion Oscillators

Pinout





Absolute Maximum Ratings

Supply Voltage Between V+ and V- Terminals	45V
Differential Input Voltage	12V
Peak Output Current Full Short Circuit Prote	ction

Operating Conditions

Temperature Range

Thermal Information

Thermal Resistance (Typical, Note 1)	θ _{JA} (°C/W)	θ _{JC} (°C/W)
Metal Can Package	165	80
Maximum Junction Temperature (Hermetic	Package)	175°C
Maximum Storage Temperature Range .	6	5°C to 150°C
Maximum Lead Temperature (Soldering 1	0s)	300°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. θ_{JA} is measured with the component mounted on a low effective thermal conductivity test board in free air. See Tech Brief TB379 for details.

Electrical Specifications $V_{SUPPLY} = \pm 15V$, Unless Otherwise Specified

PARAMETER	TEMP. (°C)	MIN	TYP	MAX	UNITS
INPUT CHARACTERISTICS					
Offset Voltage	25	-	0.5	4	mV
	Full	-	2	6	mV
Average Offset Voltage Drift	Full	-	5	-	μV/°C
Bias Current	25	-	1	10	nA
	Full	-	10	30	nA
Offset Current	25	-	1	10	nA
	Full	-	5	30	nA
Differential Input Resistance (Note 11)	25	100	500	-	MΩ
Input Noise Voltage Density (f = 1kHz)	25	-	11	-	nV/√Hz
Input Noise Current Density (f = 1kHz)	25	-	0.16	-	pA/√Hz
Common Mode Range	Full	±11	±12	-	V
TRANSFER CHARACTERISTICS					
Large Signal Voltage Gain (Notes 2, 5)	25	100	150	-	kV/V
	Full	70	-	-	kV/V
Common Mode Rejection Ratio (Note 3)	Full	80	100	-	dB
Minimum Stable Gain	25	1	-	-	V/V
Gain Bandwidth Product (Note 4)	25	-	12	-	MHz
OUTPUT CHARACTERISTICS					
Output Voltage Swing (Note 2)	Full	±10	±12	-	V
Output Current (Note 5)	25	±15	±22	-	mA
Full Power Bandwidth (Notes 5, 12)	25	50	75	-	kHz
TRANSIENT RESPONSE (Note 11)	1 1		1	1	
Rise Time (Notes 2, 6, 7, 8)	25	-	30	60	ns
Overshoot (Notes 2, 6, 7, 9)	25	-	25	40	%
Slew Rate (Notes 2, 6, 8, 13)	25	±4	±7	-	V/µs
Settling Time (Notes 2, 6, 14)	25	-	1.5	-	μs



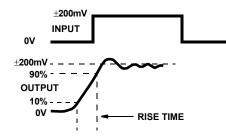
Electrical Specifications $V_{SUPPLY} = \pm 15V$, Unless Otherwise Specified (Continued)					
TEMP. (°C)	MIN	ТҮР	МАХ	UNITS	
· · ·					
25	-	3	3.7	mA	
Full	80	90	-	dB	
	TEMP. (°C) 25	TEMP. (°C) MIN 25 -	TEMP. (°C) MIN TYP 25 - 3	TEMP. (°C) MIN TYP MAX 25 - 3 3.7	

- 2. $R_L = 2k\Omega$.
- 3. $V_{CM} = \pm 10V.$
- 4. V_{OUT} < 90mV.
- 5. $V_{OUT} = \pm 10V.$
- 6. C_L = 100pF.
- 7. $V_{OUT} = \pm 200 \text{mV}.$
- 8. A_V = +1.
- 9. See Transient Response Test Circuits and Waveforms.
- 10. $\Delta V_{S} = \pm 5V.$

11. This parameter value guaranteed by design calculations. 12. Full Power Bandwidth guaranteed by slew rate measurement: FPBW = $\frac{\text{Slew Rate}}{2\pi V_{\text{PEAK}}}$

- 13. V_{OUT} = ±5V
- 14. Settling time is characterized at $A_V = -1$ to 0.1% of a 10V step.

Test Circuits and Waveforms



NOTE: Measured on both positive and negative transitions from 0V to +200mV and 0V to -200mV at the output.

FIGURE 1. TRANSIENT RESPONSE

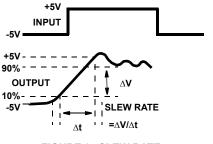
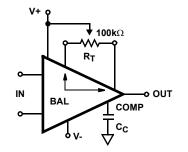


FIGURE 2. SLEW RATE



NOTE: Tested offset adjustment range is |V_{OS} + 1mV| minimum referred to output. Typical ranges are $\pm 10 \text{mV}$ with R_T = $100 \text{k}\Omega$.

FIGURE 4. SUGGESTED V_{OS} ADJUSTMENT AND **COMPENSATION HOOK UP**

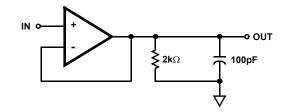
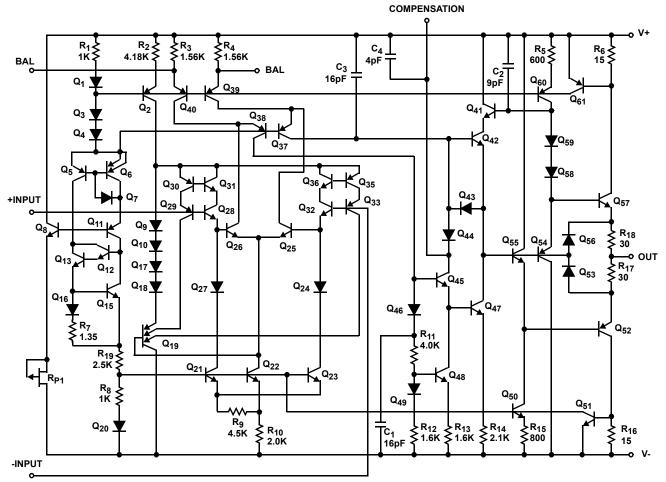


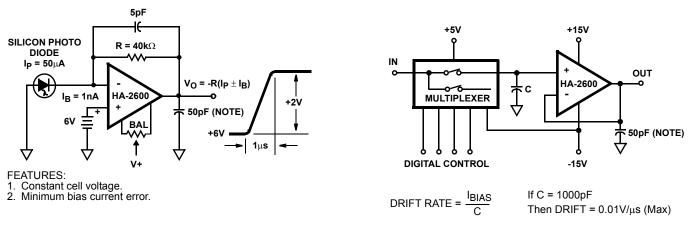
FIGURE 3. SLEW RATE AND TRANSIENT RESPONSE TEST CIRCUIT

intersil

Schematic Diagram



Typical Applications

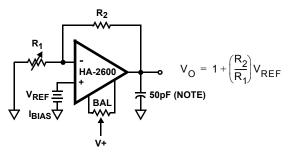


NOTE: A small load capacitance is recommended in all applications where practical to prevent possible high frequency oscillations resulting from external wiring parasitics. Capacitance up to 100pF has negligible effect on the bandwidth or slew rate.

FIGURE 5. PHOTO CURRENT TO VOLTAGE CONVERTER

FIGURE 6. SAMPLE AND HOLD

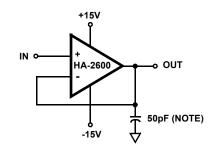
Typical Applications (Continued)



FEATURES:

1. Minimum bias current in reference cell.

2. Short Circuit Protection.

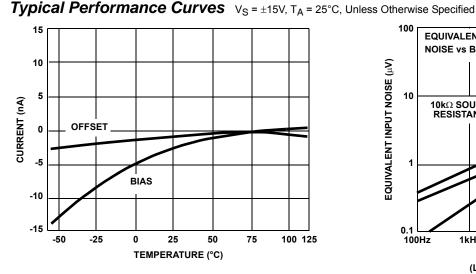


FEATURES

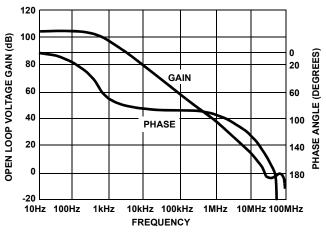
NOTE: A small load capacitance is recommended in all applications where practical to prevent possible high frequency oscillations resulting from external wiring parasitics. Capacitance up to 100pF has negligible effect on the bandwidth or slew rate.

FIGURE 7. REFERENCE VOLTAGE AMPLIFIER

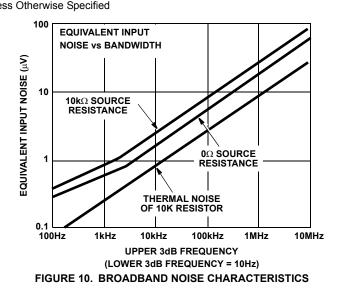












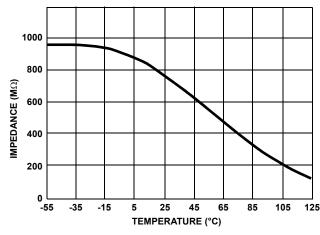


FIGURE 12. INPUT IMPEDANCE vs TEMPERATURE (100Hz)

Typical Performance Curves $V_{S} = \pm 15V$, $T_{A} = 25^{\circ}C$, Unless Otherwise Specified (Continued)

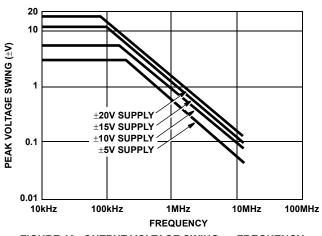
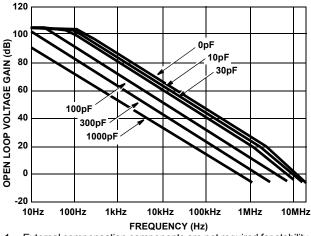
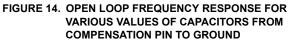
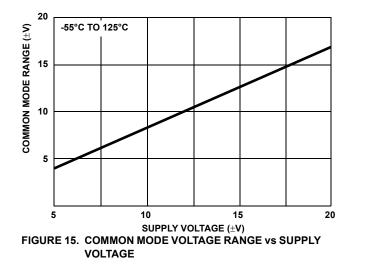


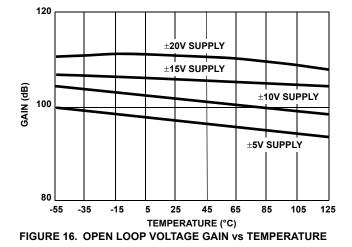
FIGURE 13. OUTPUT VOLTAGE SWING vs FREQUENCY



 External compensation components are not required for stability, but may be added to reduce bandwidth if desired. If External Compensation is used, also connect 100pF capacitor from output to ground.

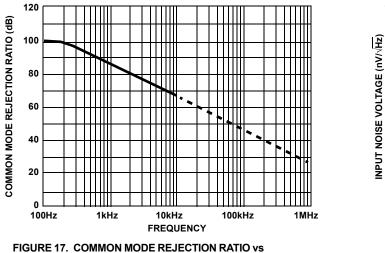




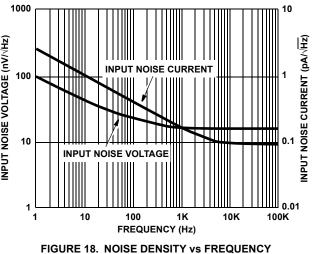


intersil

Typical Performance Curves $V_{S} = \pm 15V$, $T_{A} = 25^{\circ}C$, Unless Otherwise Specified (Continued)







Die Characteristics

SUBSTRATE POTENTIAL (Powered Up):

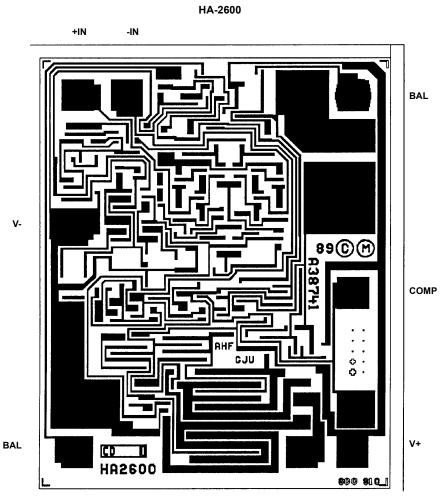
Unbiased

TRANSISTOR COUNT:

140

Metallization Mask Layout

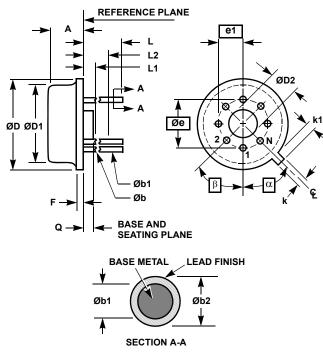
PROCESS: Bipolar Dielectric Isolation



OUT

intersil[®]

Metal Can Packages (Can)



NOTES:

- (All leads) Øb applies between L1 and L2. Øb1 applies between L2 and 0.500 from the reference plane. Diameter is uncontrolled in L1 and beyond 0.500 from the reference plane.
- 2. Measured from maximum diameter of the product.
- 3. α is the basic spacing from the centerline of the tab to terminal 1 and β is the basic spacing of each lead or lead position (N -1 places) from α , looking at the bottom of the package.
- 4. N is the maximum number of terminal positions.
- 5. Dimensioning and tolerancing per ANSI Y14.5M 1982.
- 6. Controlling dimension: INCH.

T8.C MIL-STD-1835 MACY1-X8 (A1) 8 LEAD METAL CAN PACKAGE

	INC	HES	MILLIN		
SYMBOL	MIN	MAX	MIN	MAX	NOTES
А	0.165	0.185	4.19	4.70	-
Øb	0.016	0.019	0.41	0.48	1
Øb1	0.016	0.021	0.41	0.53	1
Øb2	0.016	0.024	0.41	0.61	-
ØD	0.335	0.375	8.51	9.40	-
ØD1	0.305	0.335	7.75	8.51	-
ØD2	0.110	0.160	2.79	4.06	-
е	0.200	BSC	5.08	BSC	-
e1	0.100	BSC	2.54	2.54 BSC	
F	-	0.040	-	1.02	-
k	0.027	0.034	0.69	0.86	-
k1	0.027	0.045	0.69	1.14	2
L	0.500	0.750	12.70	19.05	1
L1	-	0.050	-	1.27	1
L2	0.250	-	6.35	-	1
Q	0.010	0.045	0.25	1.14	-
α	45 ⁰	BSC	45 ⁰ BSC		3
β	45 ⁰	BSC	45 ⁰ BSC		3
Ν	8	3	8		4

Rev. 0 5/18/94

© Copyright Intersil Americas LLC 2002-2006. All Rights Reserved. All trademarks and registered trademarks are the property of their respective owners.

For additional products, see www.intersil.com/en/products.html

Intersil products are manufactured, assembled and tested utilizing ISO9001 quality systems as noted in the quality certifications found at www.intersil.com/en/support/qualandreliability.html

Intersil products are sold by description only. Intersil may modify the circuit design and/or specifications of products at any time without notice, provided that such modification does not, in Intersil's sole judgment, affect the form, fit or function of the product. Accordingly, the reader is cautioned to verify that datasheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.

For information regarding Intersil Corporation and its products, see www.intersil.com

